

INFORMATION DISCLOSURE  
CITATION IN AN  
APPLICATION

(PTO-1449)

ATTY. DOCKET NO.  
**62807-037**

SERIAL NO.

APPLICANT  
**Shinji ITO, et al.**

FILING DATE  
**February 14, 2002**

GROUP

bc979 U.S. PTO  
10/074239

02/14/02

## U.S. PATENT DOCUMENTS

| EXAMINER'S<br>INITIALS | PATENT NO. | DATE      | NAME         | CLASS | SUBCLASS | FILING DATE |
|------------------------|------------|-----------|--------------|-------|----------|-------------|
| <i>6</i>               | 5,940,591  | 8/17/1999 | Boyle et al. |       |          |             |
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## FOREIGN PATENT DOCUMENTS

| EXAMINER'S<br>INITIALS | PATENT NO. | DATE | COUNTRY | CLASS | SUBCLASS | Translation |    |
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|                        |            |      |         |       |          | Yes         | No |
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## OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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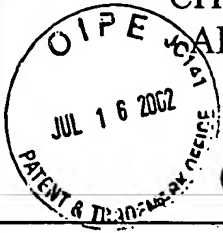
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

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**10/074,239**

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GROUP  
**2131**

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|---------------------|------------|------|------|-------|----------|-------------|
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## FOREIGN PATENT DOCUMENTS

| EXAMINER'S INITIALS | PATENT NO. | DATE      | COUNTRY                     | CLASS | SUBCLASS | Translation |    |
|---------------------|------------|-----------|-----------------------------|-------|----------|-------------|----|
|                     |            |           |                             |       |          | Yes         | No |
| <i>HS</i>           | 8-204701   | 8/9/1996  | Japan (w/ English Abstract) |       |          |             |    |
| <i>HS</i>           | 11-149385  | 6/2/1999  | Japan (w/ English Abstract) |       |          |             |    |
| <i>HS</i>           | 11-85546   | 3/30/1999 | Japan (w/ English Abstract) |       |          |             |    |
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## OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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| <i>B</i> | "Department of Defense Trusted Computer System Evaluation Criteria", DOD, 5200.28-STD, December 26, 1985, pp. 1-116. |
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SHEET 1 OF 1

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CITATION IN AN  
APPLICATIONATTY. DOCKET NO.  
**062807-0037**SERIAL NO.  
**10/074,239**APPLICANT  
**Shinji ITOH, et al.**

(PTO-1449)

FILING DATE  
**February 14, 2002**GROUP  
**2131**

## U.S. PATENT DOCUMENTS

| EXAMINER'S<br>INITIALS | CITE<br>NO. | Document Number<br>Number-Kind Code <sup>2</sup> (if known) | Publication Date<br>MM-DD-YYYY | Name of Patentee or Applicant of Cited<br>Document | Pages, Columns, Lines, Where<br>Relevant Passages or Relevant<br>Figures Appear |
|------------------------|-------------|---|--------------------------------|--|---|
|                        |             | US 5,577,209  | 11/19/1996                     | Boyle et al.                                       |   |
|                        |             | US 5,680,452  | 10/21/1997                     | Shanton  |   |
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## FOREIGN PATENT DOCUMENTS

| EXAMINER'S<br>INITIALS | CITE<br>NO. | Foreign Patent Document<br>Country Codes-Number &-Kind<br>Codes (if known) | Publication Date<br>MM-DD-YYYY | Name of Patentee or<br>Applicant of Cited Document | Pages,<br>Columns,<br>Lines Where<br>Relevant<br>Figures<br>Appear | Translation                      |    |
|------------------------|-------------|--|--------------------------------|--|--|----------------------------------|----|
|                        |             |  |                                |  |  | Yes                              | No |
|                        |             | WO 00/10278  | 02/24/2000                     | CRYPTIK SECURE<br>COMMUNICATIONS, LLC.             |  | X                                |    |
|                        |             | EP 0 743 777 A2  | 11/20/1996                     | SUN MICROSYSTEMS, INC.                             |  | X                                |    |
|                        |             | JP 11-149385   | 06/02/1999                     | HITACHI LTD.                                       |  | JAPAN<br>(w/ENGLISH<br>ABSTRACT) |    |
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1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

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